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### SPP15N60CFD-VB Datasheet

# N-Channel 650 V (D-S) Super Junction MOSFET

PRODUCT SUMMA	RY			
V <sub>DS</sub> (V) at T <sub>J</sub> max.	650			
R <sub>DS(on)</sub> (Ω) at 25 °C	$V_{GS} = 10 V$	0.19		
Q <sub>g</sub> max. (nC)	106			
Q <sub>gs</sub> (nC)	14			
Q <sub>gd</sub> (nC)	33			
Configuration	Sing	le		

### **FEATURES**

- Reduced t<sub>rr</sub>, Q<sub>rr</sub>, and I<sub>RRM</sub>
- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Low switching losses due to reduced Q<sub>rr</sub>
- Ultra low gate charge (Q<sub>a</sub>)
- Avalanche energy rated (UIS)

### **APPLICATIONS**

- Telecommunications
  - Server and telecom power supplies
- Lighting
  - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Consumer and computing
  - ATX power supplies
- Industrial
  - Welding
  - Battery chargers
- Renewable energy
  - Solar (PV inverters)
- Switch mode power supplies (SMPS)

ABSOLUTE MAXIMUM RATINGS (T <sub>C</sub> :	= 25 °C, unless otherw	ise noted)			
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		V <sub>DS</sub>	650	V	
Gate-Source Voltage		V <sub>GS</sub>	± 30	v	
Continuous Drain Current (T <sub>1</sub> = 150 °C)	50 °C) $V_{GS}$ at 10 V $\frac{T_{C} = 25 °C}{T_{C} = 100 °C}$ $I_{D}$		20		
Continuous Drain Current $(1_j = 150 \text{ C})$	$T_{\rm C} = 100 ^{\circ}{\rm C}$	I <sub>D</sub>	13	А	
Pulsed Drain Current <sup>a</sup>		I <sub>DM</sub>	60		
Linear Derating Factor			1.7	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>		E <sub>AS</sub>	367	mJ	
Maximum Power Dissipation		PD	208	W	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C	
Drain-Source Voltage Slope T <sub>J</sub> = 125 °C		d\//dt	37	V/ns	
Reverse Diode dV/dt <sup>d</sup>		dV/dt	31	v/ns	
Soldering Recommendations (Peak Temperature) <sup>c</sup>	for 10 s		300	°C	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD} = 50$  V, starting T<sub>J</sub> = 25 °C, L = 28.2 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 5.1 A.

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N-Channel MOSFET

c. 1.6 mm from case.

d.  $I_{SD} \leq I_D$ , dl/dt = 100 A/µs, starting  $T_J$  = 25 °C.

**TO-220AB** ( ) GC

GDS

Top View

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PARAMETER	SYMBOL	TYP.		MAX.			UNIT	
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-		62				
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	- 0.5			°C/W		
<b>SPECIFICATIONS</b> ( $T_J = 25 \ ^{\circ}C$ ,	unless otherw	ise noted)						
PARAMETER	SYMBOL	1		NS	MIN.	TYP.	MAX.	
Static								1
Drain-Source Breakdown Voltage	V <sub>DS</sub>	Ves	= 0 V, I <sub>D</sub> = 25	i0 µA	650	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_J$		e to 25 °C, I <sub>C</sub>		-	0.67	-	V/°C
Gate-Source Threshold Voltage (N)	V <sub>GS(th)</sub>		= V <sub>GS</sub> , I <sub>D</sub> = 25		2	-	4	V
	GO(iii)		$V_{GS} = \pm 20 V$		-	-	± 100	nA
Gate-Source Leakage	I <sub>GSS</sub>		$V_{GS} = \pm 30 V$		-	-	± 1	μA
	<u> </u>		= 520 V, V <sub>GS</sub>		-	-	1	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>			$V_{GS} = 0 V, T_J = 125 °C$		-	500	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V		= 11 A	-	0.19	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 30 V, I <sub>D</sub> = 11 A		-	7.0	-	S	
Dynamic		-			•	•	•	•
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V,		-	2322	-		
Output Capacitance	C <sub>oss</sub>		$V_{DS} = 100 V,$		-	105	-	-
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1 MHz V <sub>DS</sub> = 0 V to 520 V, V <sub>QS</sub> = 0 V		-	4	-	pF	
Effective Output Capacitance, Energy Related <sup>a</sup>	C <sub>o(er)</sub>			-	84	-		
Effective Output Capacitance, Time Related <sup>b</sup>	C <sub>o(tr)</sub>	$v_{\rm DS} = 0.0$	v to 520 v, v <sub>i</sub>	<sub>GS</sub> = 0 V	-	293	-	
Total Gate Charge	Qg				-	71	106	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	I <sub>D</sub> = 11 A	V <sub>DS</sub> = 520 V	-	14	-	nC
Gate-Drain Charge	Q <sub>gd</sub>				-	33	-	
Turn-On Delay Time	t <sub>d(on)</sub>		•		-	22	44	
Rise Time	t <sub>r</sub>	$\label{eq:VDD} \begin{array}{l} V_{\text{DD}} = 520 \; \text{V}, \; I_{\text{D}} = 11 \; \text{A}, \\ V_{\text{GS}} = 10 \; \text{V}, \; R_{g} = 9.1 \; \Omega \end{array}$		-	34	68	- ns	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	68	102		
Fall Time	t <sub>f</sub>			-	42	84		
Gate Input Resistance	R <sub>g</sub>	f = 1 MHz, open drain		-	0.78	-	Ω	
Drain-Source Body Diode Characterist								
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET sym showing the	bol		-	-	21	
Pulsed Diode Forward Current	I <sub>SM</sub>	integral revers p - n junction			-	-	53	A
Diode Forward Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °0	C, I <sub>S</sub> = 11 A,	V <sub>GS</sub> = 0 V	-	0.9	1.2	V
Reverse Recovery Time	t <sub>rr</sub>				-	160	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 2$	5 °C, I <sub>F</sub> = I <sub>S</sub> =	= 11 A,	-	1.2	-	μC
Reverse Recovery Current	I <sub>RRM</sub>	ai/at =	100 A/µs, V <sub>F</sub>	= 25 V	-	14	_	A

#### Notes

a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

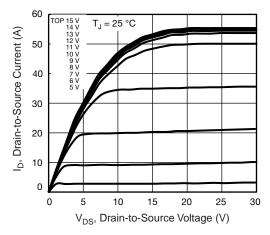


Fig. 1 - Typical Output Characteristics



Fig. 2 - Typical Output Characteristics

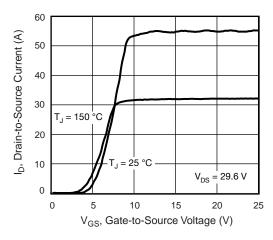


Fig. 3 - Typical Transfer Characteristics

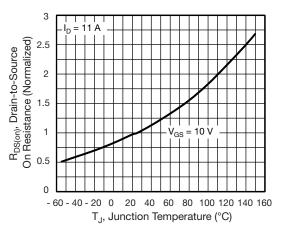


Fig. 4 - Normalized On-Resistance vs. Temperature

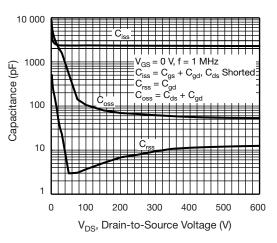


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

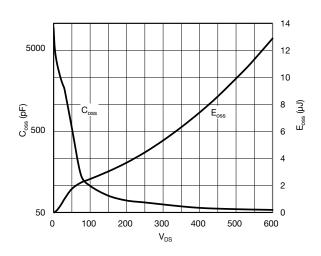


Fig. 6 -  $C_{oss}$  and  $E_{oss}$  vs.  $V_{DS}$ 

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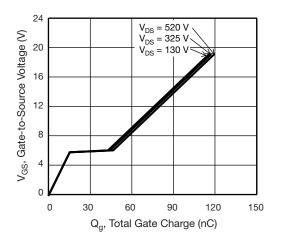


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

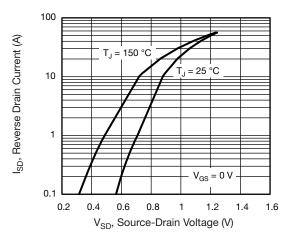


Fig. 8 - Typical Source-Drain Diode Forward Voltage

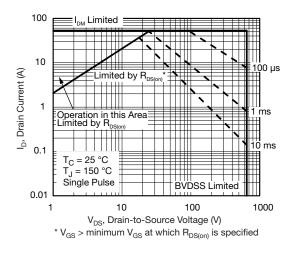


Fig. 9 - Maximum Safe Operating Area

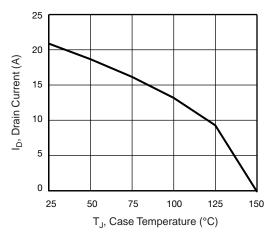


Fig. 10 - Maximum Drain Current vs. Case Temperature

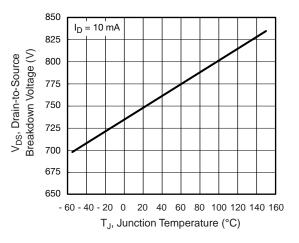


Fig. 11 - Temperature vs. Drain-to-Source Voltage





Fig. 12 - Normalized Thermal Transient Impedance, Junction-to-Case



Fig. 13 - Switching Time Test Circuit



Fig. 14 - Switching Time Waveforms

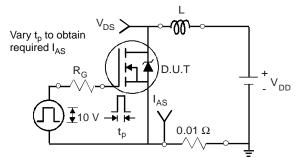


Fig. 15 - Unclamped Inductive Test Circuit

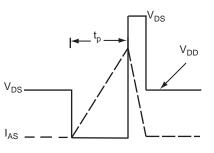


Fig. 16 - Unclamped Inductive Waveforms

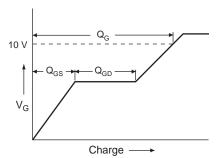
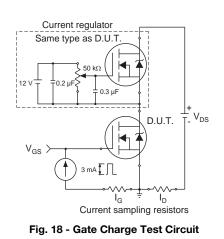
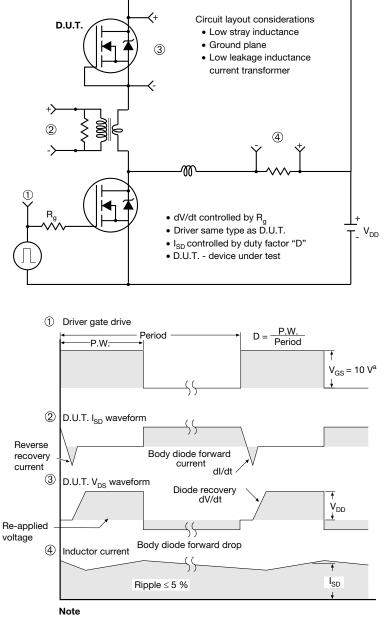


Fig. 17 - Basic Gate Charge Waveform





### Peak Diode Recovery dV/dt Test Circuit



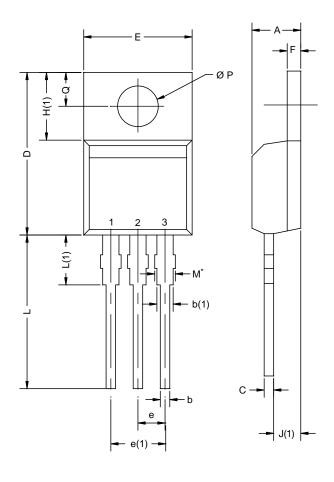
a.  $V_{GS} = 5$  V for logic level devices

Fig. 19 - For N-Channel

# SPP15N60CFD-VB



# **TO-220AB**



DIM.	MILLIN	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.		
А	4.25	4.65	0.167	0.183		
b	0.69	1.01	0.027	0.040		
b(1)	1.20	1.73	0.047	0.068		
С	0.36	0.61	0.014	0.024		
D	14.85	15.49	0.585	0.610		
Е	10.04	10.51	0.395	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.09	6.48	0.240	0.255		
J(1)	2.41	2.92	0.095	0.115		
L	13.35	14.02	0.526	0.552		
L(1)	3.32	3.82	0.131	0.150		
ØΡ	3.54	3.94	0.139	0.155		
Q	2.60	3.00	0.102	0.118		

#### Notes

\* M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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